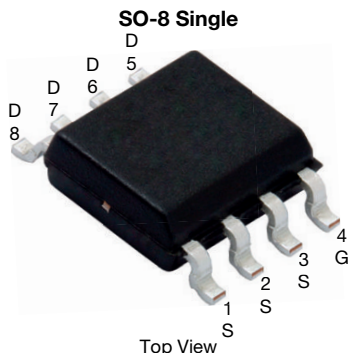


N-Channel 100 V (D-S) MOSFET



FEATURES

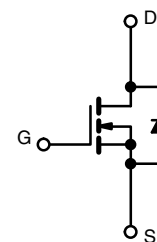
- TrenchFET® Gen IV power MOSFET
- Very low $R_{DS} \times Q_g$ figure-of-merit (FOM)
- Tuned for the lowest $R_{DS} \times Q_{oss}$ FOM
- Logic level gate drive
- 100 % R_g and UIS tested
- Material categorization: for definitions of compliance please see www.vishay.com/doc?99912



RoHS
COMPLIANT
HALOGEN
FREE

APPLICATIONS

- Synchronous rectification
- Primary side switch
- DC/DC converter
- Motor drive switch
- LED driver
- Load switch



N-Channel MOSFET

PRODUCT SUMMARY

V_{DS} (V)	100
$R_{DS(on)}$ max. (Ω) at $V_{GS} = 10$ V	0.093
$R_{DS(on)}$ max. (Ω) at $V_{GS} = 4.5$ V	0.0103
Q_g typ. (nC)	28
I_D (A)	17
Configuration	Single

ORDERING INFORMATION

Package	SO-8
Lead (Pb)-free and halogen-free	Si4190BDY-T1-GE3

ABSOLUTE MAXIMUM RATINGS ($T_A = 25^\circ\text{C}$, unless otherwise noted)

PARAMETER	SYMBOL	LIMIT	UNIT
Drain-source voltage	V_{DS}	100	V
Gate-source voltage	V_{GS}	± 20	V
Continuous drain current ($T_J = 150^\circ\text{C}$)	$T_C = 25^\circ\text{C}$	17	A
	$T_C = 70^\circ\text{C}$	13.6	
	$T_A = 25^\circ\text{C}$	12 ^{b, c}	
	$T_A = 70^\circ\text{C}$	9.6 ^{b, c}	
Pulsed drain current ($t = 100 \mu\text{s}$)	I_{DM}	130	A
Continuous source-drain diode current	$T_C = 25^\circ\text{C}$	5.4	A
	$T_A = 25^\circ\text{C}$	2.7 ^{b, c}	
Single pulse avalanche current	I_{AS}	30	mJ
Single pulse avalanche energy	E_{AS}	45	
Maximum power dissipation	$T_C = 25^\circ\text{C}$	8.4	W
	$T_C = 70^\circ\text{C}$	5.9	
	$T_A = 25^\circ\text{C}$	3.8 ^{b, c}	
	$T_A = 70^\circ\text{C}$	3.0 ^{b, c}	
Operating junction and storage temperature range	T_J, T_{stg}	-55 to +150	$^\circ\text{C}$
Soldering recommendations (peak temperature) ^c		260	

THERMAL RESISTANCE RATINGS

PARAMETER	SYMBOL	TYPICAL	MAXIMUM	UNIT
Maximum junction-to-ambient ^b	R_{thJA}	33	42	$^\circ\text{C/W}$
Maximum junction-to-case (drain)	R_{thJC}	16	21	

Notes

- $T_C = 25^\circ\text{C}$
- Surface mounted on 1" x 1" FR4 board
- $t = 10$ s
- Maximum under steady state conditions is 85°C/W

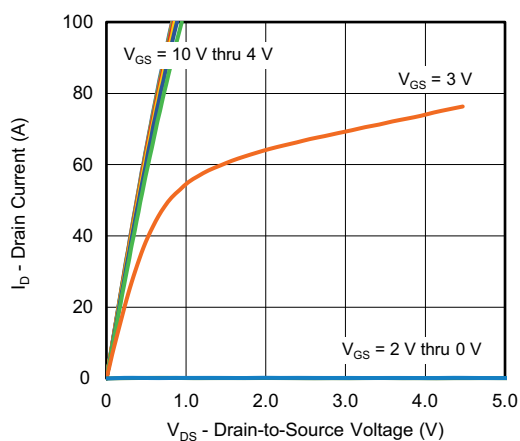
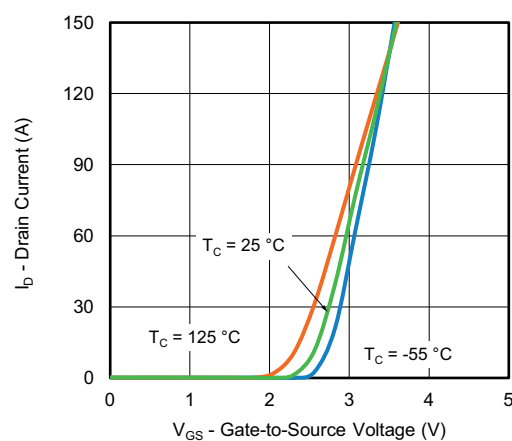
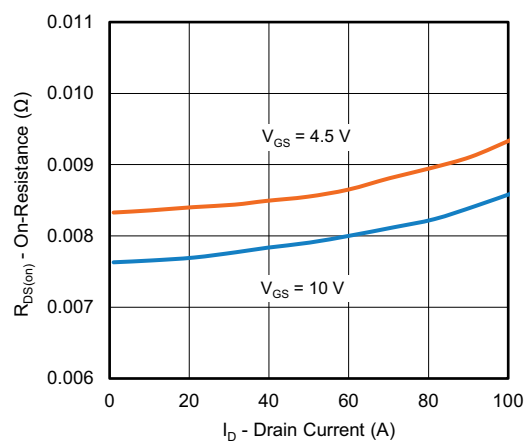
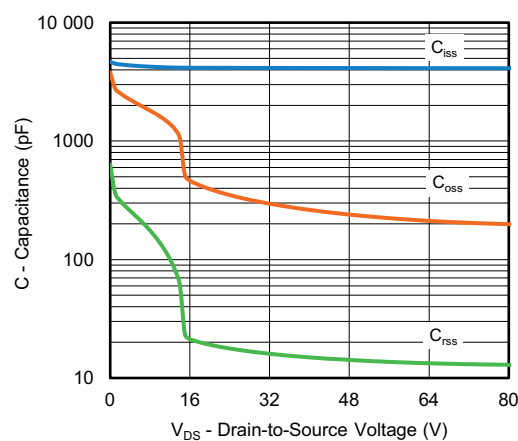
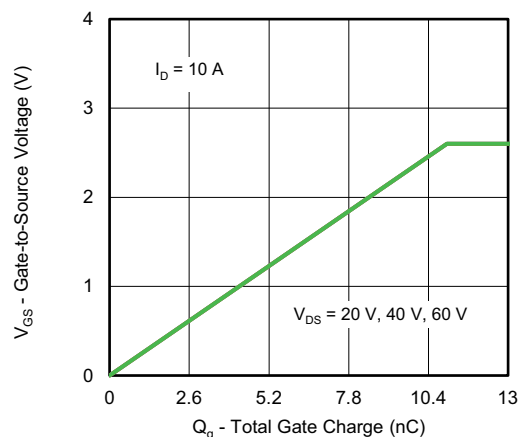
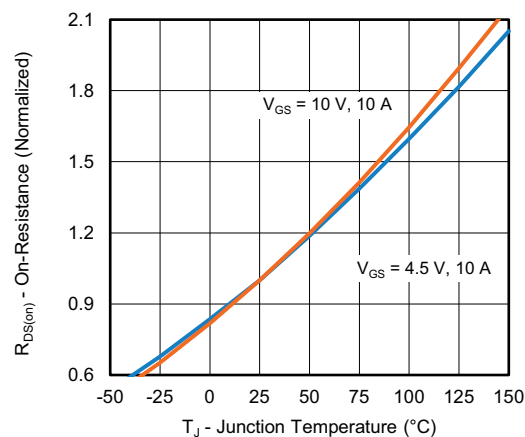


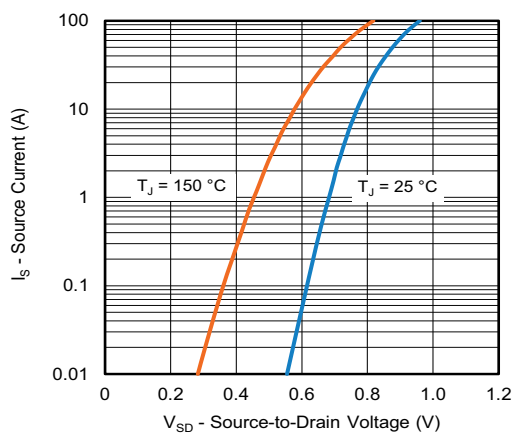
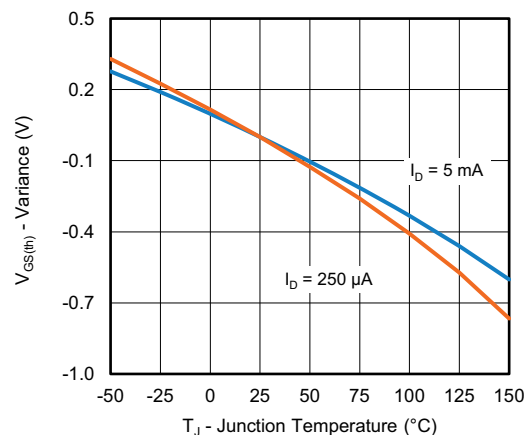
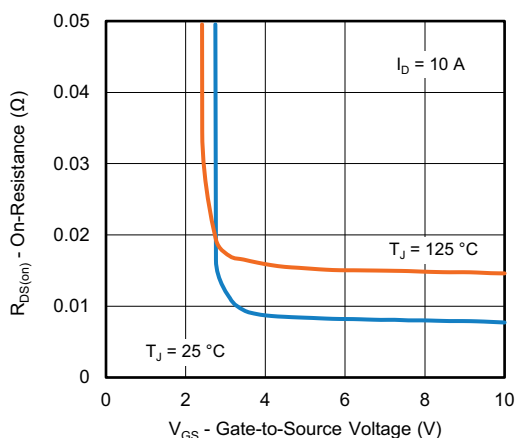
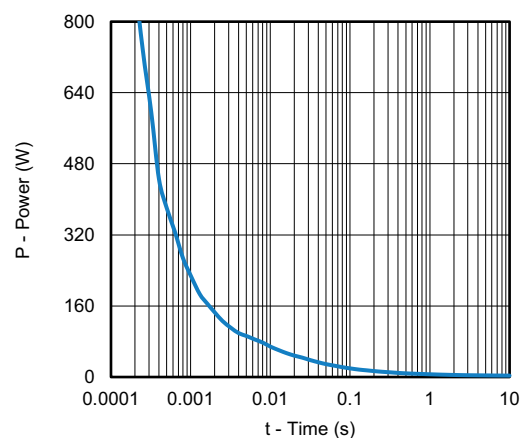
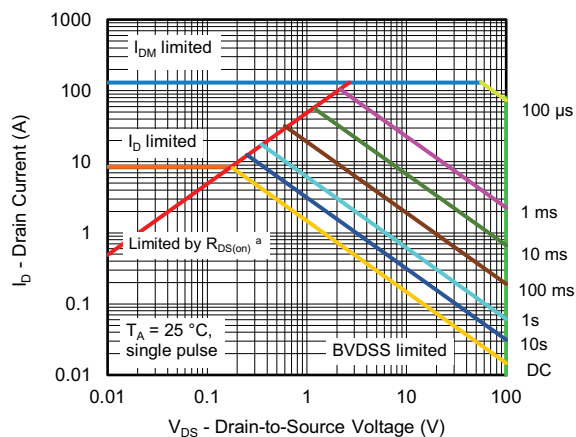
SPECIFICATIONS (T _J = 25 °C, unless otherwise noted)							
PARAMETER	SYMBOL	TEST CONDITIONS	MIN.	TYP.	MAX.	UNIT	
Static							
Drain-source breakdown voltage	V _{DS}	V _{GS} = 0 V, I _D = 250 μA	100	-	-	V	
V _{DS} temperature coefficient	ΔV _{DS} /T _J	I _D = 10 mA	-	85	-	mV/°C	
V _{GS(th)} temperature coefficient	ΔV _{GS(th)} /T _J	I _D = 250 μA	-	-5.1	-		
Gate-source threshold voltage	V _{GS(th)}	V _{DS} = V _{GS} , I _D = 250 μA	1	-	2.5	V	
Gate-source leakage	I _{GSS}	V _{DS} = 0 V, V _{GS} = ± 20 V	-	-	100	nA	
Zero gate voltage drain current	I _{DSS}	V _{DS} = 100 V, V _{GS} = 0 V	-	-	1	μA	
		V _{DS} = 100 V, V _{GS} = 0 V, T _J = 70 °C	-	-	15		
Drain-source on-state resistance ^a	R _{DS(on)}	V _{GS} = 10 V, I _D = 10 A	-	0.0077	0.0093	Ω	
		V _{GS} = 4.5 V, I _D = 10 A	-	0.0084	0.0103		
Forward transconductance ^a	g _{fs}	V _{DS} = 15 V, I _D = 10 A	-	100	-	S	
Dynamic ^b							
Input capacitance	C _{iSS}	V _{DS} = 50 V, V _{GS} = 0 V, f = 1 MHz	-	4150	-	pF	
Output capacitance	C _{oss}		-	235	-		
Reverse transfer capacitance	C _{rss}		-	14	-		
Total gate charge	Q _g	V _{DS} = 50 V, V _{GS} = 10 V, I _D = 10 A	-	62	95	nC	
Gate-source charge	Q _{gs}	V _{DS} = 50 V, V _{GS} = 4.5 V, I _D = 10 A	-	28	42		
Gate-drain charge	Q _{gd}		-	11	-		
Output charge	Q _{oss}		-	5.5	-		
Gate resistance	R _g	V _{DS} = 50 V, V _{GS} = 0 V	-	39.5	-	Ω	
Turn-on delay time	t _{d(on)}	f = 1 MHz	0.3	0.87	1.5	ns	
Rise time	t _r	V _{DD} = 50 V, R _L = 5 Ω, I _D ≅ 10 A, V _{GEN} = 10 V, R _g = 1 Ω	-	13	26		
Turn-off delay time	t _{d(off)}		-	5	10		
Fall time	t _f		-	35	70		
Turn-on delay time	t _{d(on)}		-	5	10		
Rise time	t _r	V _{DD} = 50 V, R _L = 5 Ω, I _D ≅ 10 A, V _{GEN} = 4.5 V, R _g = 1 Ω	-	28	56		
Turn-off delay time	t _{d(off)}		-	22	44		
Fall time	t _f		-	36	72		
			-	7	14		
Drain-Source Body Diode Characteristics							
Continuous source-drain diode current	I _S	T _C = 25 °C	-	-	5.4		A
Pulse diode forward current	I _{SM}		-	-	130		
Body diode voltage	V _{SD}	I _S = 5 A, V _{GS} = 0 V	-	0.74	1.1	V	
Body diode reverse recovery time	t _{rr}	I _F = 10 A, di/dt = 100 A/μs, T _J = 25 °C	-	39	78	ns	
Body diode reverse recovery charge	Q _{rr}		-	68	136	nC	
Reverse recovery fall time	t _a		-	33	-	ns	
Reverse recovery rise time	t _b		-	6	-		

Notes

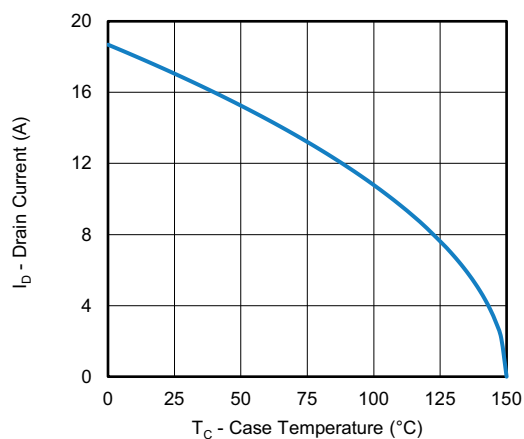
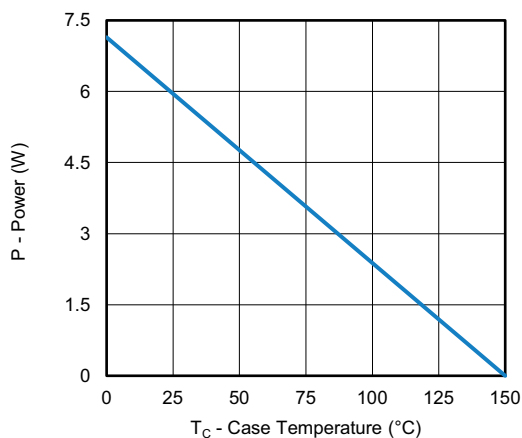
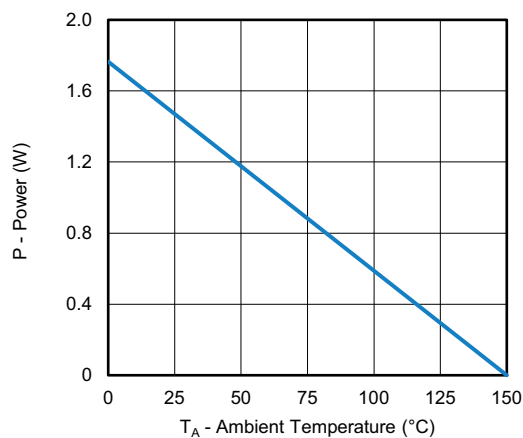
- a. Pulse test; pulse width ≤ 300 μs, duty cycle ≤ 2 %
b. Guaranteed by design, not subject to production testing

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

Output Characteristics

Transfer Characteristics

On-Resistance vs. Drain Current and Gate Voltage

Capacitance

Gate Charge

On-Resistance vs. Junction Temperature

TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

Source-Drain Diode Forward Voltage

Threshold Voltage

On-Resistance vs. Gate-to-Source Voltage

Single Pulse Power, Junction-to-Ambient

Safe Operating Area, Junction-to-Ambient
Note

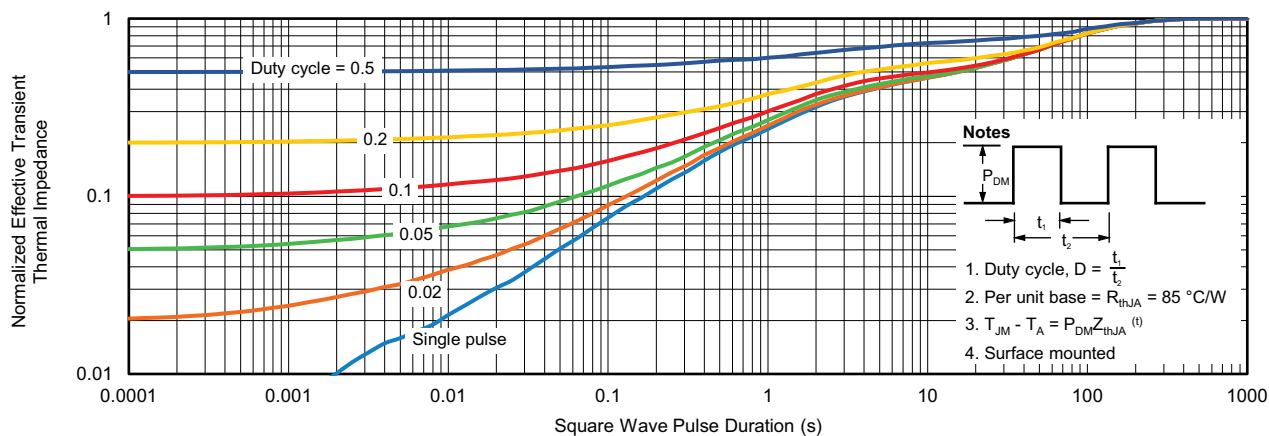
a. $V_{GS} >$ minimum V_{GS} at which $R_{DS(on)}$ is specified

TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

Current Derating ^a

Power, Junction-to-Case

Power, Junction-to-Ambient
Note

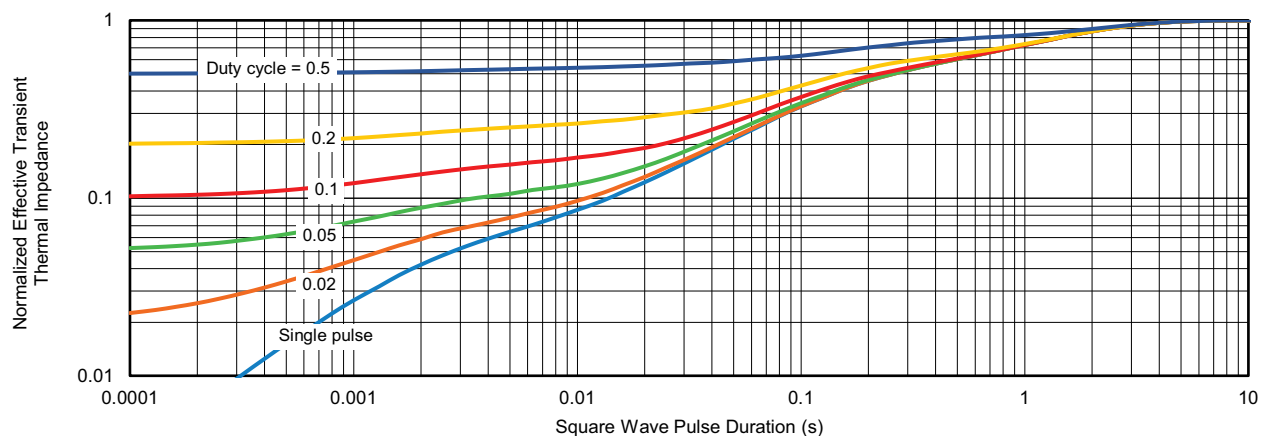
- a. The power dissipation P_D is based on T_J max. = 150 °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.



TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



Normalized Thermal Transient Impedance, Junction-to-Ambient



Normalized Thermal Transient Impedance, Junction-to-Case

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